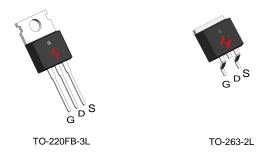


#### N-Channel Enhancement Mode MOSFET

### **Feature Description**

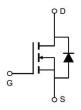
- 200V/90A $R_{DS(ON)} = 22m\Omega(typ.)@V_{GS} = 10V$
- 100% Avalanche Tested
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

#### **Pin Description**



### **Applications**

Power Management for Inverter Systems



N-Channel MOSFET

## **Ordering and Marking Information**





Package Code

P: TO-220FB-3L

B: TO-263-2L

Date Code YYXXX WW Assembly Material G:lead Free Device

Note: HUAYI lead -free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI lead -free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defi nes "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice.



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Unit	
Common Rat	ings (Tc=25°C Unless Otherwise Noted)			
VDSS	Drain-Source Voltage		200	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		175	°C
Tstg	Storage Temperature Range		-55 to 175	°C
ls	Source Current-Continuous(Body Diode)		90	А
Mounted on I	Large Heat Sink	,		•
Ідм	Pulsed Drain Current *	Tc=25°C	360	А
	Cantinua Dania Cumant	Tc=25°C	90	А
lo	Continuous Drain Current	Tc=100°C	70	А
-	N	Tc=25°C	375	W
PD	P <sub>D</sub> Maximum Power Dissipation Tc=100°C		187.5	W
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case		0.4	°C/W
R <sub>eJA</sub>	Thermal Resistance, Junction-to-Ambient **		62.5	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.5mH	784	mJ

Note: \* Repetitive rating; pulse width limited by max. junction temperature.

### Electrical Characteristics (Tc = 25°C Unless Otherwise Noted)

Cumbal	Downworton	Toot Cor	aliti a ma	HY1920		Unit	
Symbol	ymbol Parameter Test Conditions		Min	Тур.	Max	Unit	
Static Char	Static Characteristics						
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V,I <sub>DS</sub> =2	50μΑ	200	-		V
Inno	VDS=200V,VGS=0V		s=0V	-	-	1	μA
IDSS	Drain-to-Source Leakage Current		TJ=55°C	-	-	5	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =	=250μΑ	2.0	3.0	4.0	V
Igss	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$		-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V <sub>GS</sub> =10V,I <sub>DS</sub> =45A			22.0	24.0	mΩ
Diode Chai	Diode Characteristics						
V <sub>SD</sub> *	Diode Forward Voltage	I <sub>SD</sub> =45A,V <sub>GS</sub> =0V		-	0.82	1.1	V
trr	Reverse Recovery Time	1 -450 dl /dt-4000/			80	-	ns
Qrr	Reverse Recovery Charge	IsD=45A,dIsD/dt=100A/µs		-	160	-	nC

<sup>\*\*</sup> Surface mounted on FR-4 board.

<sup>\*\*\*</sup> Limited by TJmax , starting TJ=25°C, L = 0.5mH, RG= 25 $\Omega$ , VGS =10V.



# Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Danamatan.	Took Conditions		HY1920		1114
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V <sub>GS</sub> =0V,V <sub>DS</sub> =0V, F=1MHz	-	3.4	-	Ω
Ciss	Input Capacitance	V <sub>GS</sub> =0V,	-	5871	-	
Coss	Output Capacitance	V <sub>DS</sub> =25V,	-	392	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	165	-	
td(ON)	Turn-on Delay Time		-	29	-	
Tr	Turn-on Rise Time	$V_{DD}$ =100 $V$ , $R_{G}$ =4 $\Omega$ ,	-	45	-	]
td(OFF)	Turn-off Delay Time	IDS=45A,VGS=10V	-	22	-	ns
Tf	Turn-off Fall Time		-	41	-	]
Gate Cha	rge Characteristics		•			
Qg	Total Gate Charge	\/ -400\/ \/ -40\/	-	130.4	-	
Qgs	Gate-Source Charge	$V_{DS} = 160 \text{V}, V_{GS} = 10 \text{V},$	-	22.1	-	nC
Qgd	Gate-Drain Charge	I <sub>D</sub> =45A	-	38.2	-	

Note: \*Pulse test, pulse width  $\leq 300$ us, duty cycle  $\leq 2\%$ 



# **Typical Operating Characteristics**

**Figure 1: Power Dissipation** 

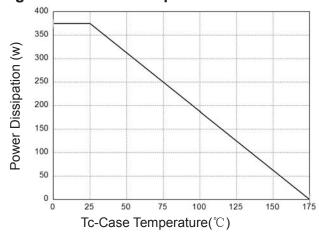
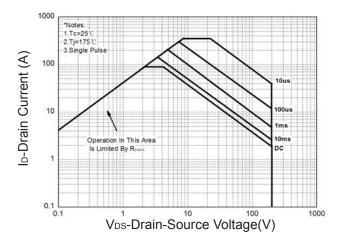


Figure 3: Safe Operation Area



**Figure 5: Output Characteristics** 

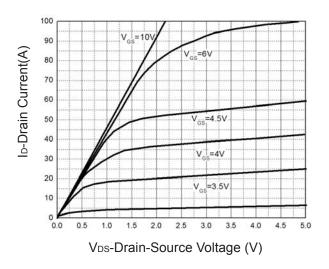


Figure 2: Drain Current

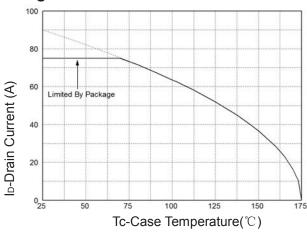


Figure 4: Thermal Transient Impedance

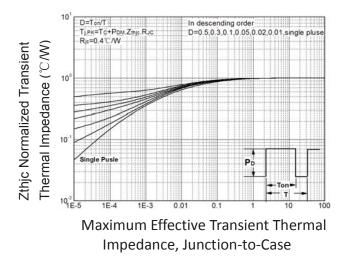
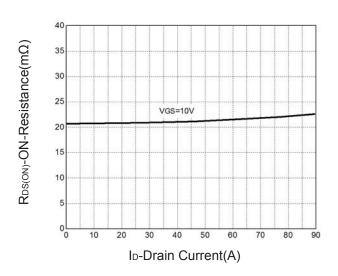


Figure 6: Drain-Source On Resistance





### **Typical Operating Characteristics(Cont.)**

Figure 7: Gate-Source Vs. On-Resistance

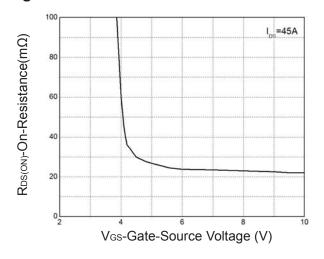


Figure 8: Gate-Source Forward

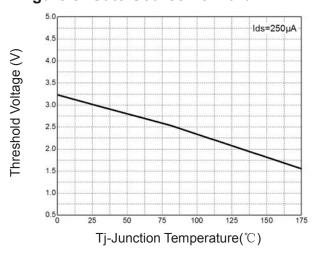
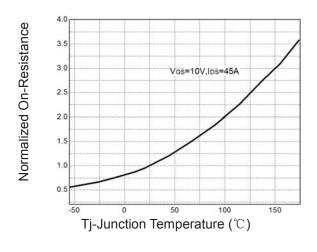


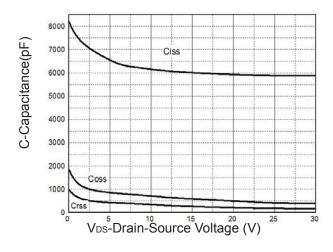
Figure 9: On-Resistance vs. Temperature

Figure 10: Source-Drain Diode Forward

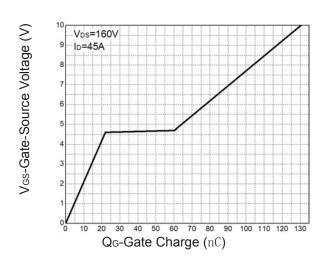


(V) Ti=175°C Ti=25°C VGS=0V VGS=0V VSD, Source-Drain Voltage(V)

**Figure 11: Capacitance Characteristics** 

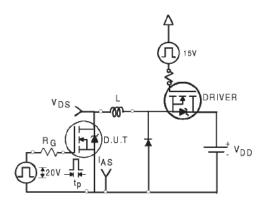


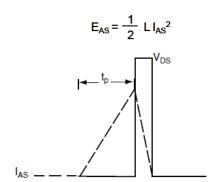
**Figure 12: Gate Charge Characteristics** 



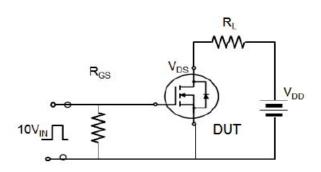


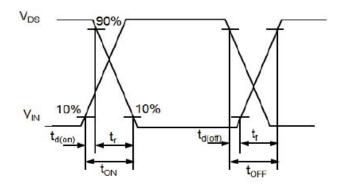
### **Avalanche Test Circuit**



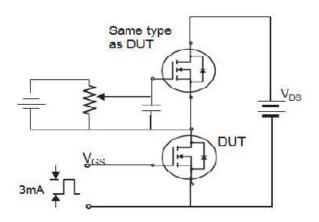


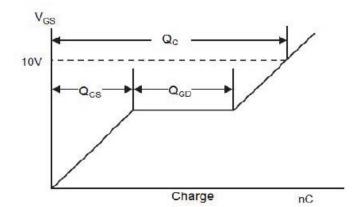
# **Switching Time Test Circuit**





# **Gate Charge Test Circuit**





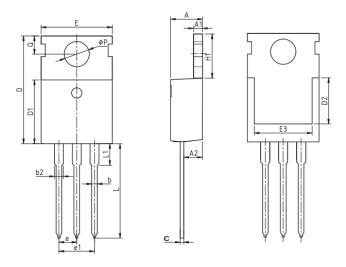


### **Device Per Unit**

Package Type	Unit	Quantity
TO-220FB-3L	Tube	50

# **Package Information**

## TO-220FB-3L



#### **COMMON DIMENSIONS**

CVMPOL		mm	
SYMBOL	MIN	NOM	MAX
А	4.37	4.57	4.77
A1	1.25	1.30	1.45
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
С	0.40	0.50	0.65
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	-	-
E	9.70	10.00	10.30
E3	7.00	-	-
е		2.54 BSC	
e1		5.08 BSC	
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ФР	3.40	3.60	3.80
Q	2.60	2.80	3.00

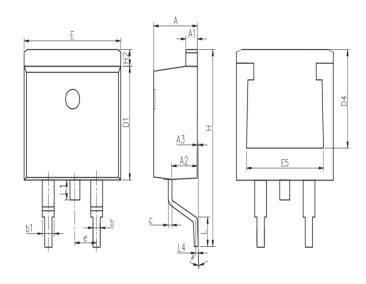


## **Device Per Unit**

Package Type	Unit	Quantity
TO-263-2L	Reel	50

# **Package Information**

## TO-263-2L

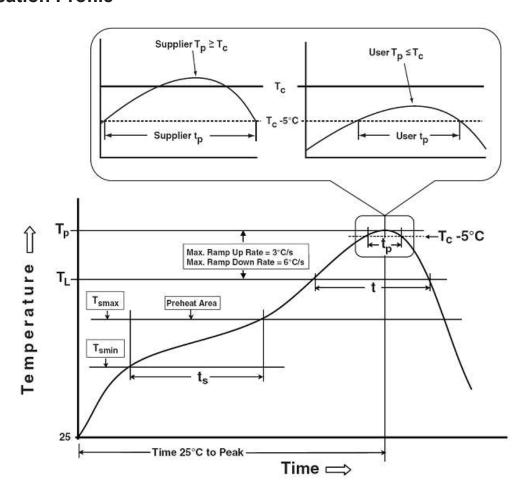


#### **COMMON DIMENSIONS**

SYMBOL	mm		
STIVIBOL	MIN	NOM	MAX
А	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0	0.13	0.25
b	0.7	0.81	0.96
b1	1.17	1.27	1.47
С	0.3	0.38	0.53
D1	8.5	8.7	8.9
D4	6.6	-	-
Е	9.86	10.16	10.36
E5	7.06	-	-
е		2.54 BSC	;
Н	14.7	15.1	15.5
H2	1.07	1.27	1.47
L	2	2.3	2.6
L1	1.4	1.55	1.7
L4	0.25 BSC		
θ	0°	5°	9°



### **Classification Profile**



### **Classification Reflow Profiles**

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly		
Preheat & Soak	100 °C	150 °C		
Temperature min (T <sub>smin</sub> )	150 °C	200 °C		
Temperature max (T <sub>smax</sub> )	60-120 seconds	60-120 seconds		
Time (Tsmin to Tsmax) (t₅)	00-120 seconds	00-120 seconds		
Average ramp-up rate	2 °C/second may	2°C/22221d may		
(T <sub>smax</sub> to T <sub>P</sub> )	3 °C/second max.	3°C/second max.		
Liquidous temperature (T <sub>L</sub> )	183 °C	217 °C		
Time at liquidous (t <sub>L</sub> )	60-150 seconds	60-150 seconds		
Peak package body Temperature	See Classification Temp in table 1	See Classification Temp in table 2		
(T <sub>p</sub> )*	See Classification Temp in table 1	See Classification Temp in table 2		
Time (t <sub>P</sub> )** within 5°C of the specified	20** accords	20** accords		
classification temperature (T <sub>c</sub> )	20** seconds	30** seconds		
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.		
Time 25°C to peak temperature	6 minutes max.	8 minutes max.		

<sup>\*</sup>Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

<sup>\*\*</sup> Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

### HY1920P/B



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

#### Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

## **Reliability Test Program**

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168 Hrs/500 Hrs/1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -55°C~150°C

#### **Customer Service**

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